

Notice of References Cited	Application/Control No. 10/757,597	Applicant(s)/Patent Under Reexamination NISHIO ET AL.	
	Examiner HELEN SHIBRU	Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0008175	01-2006	Tanaka et al.	382/276
*	B	US-2002/0090196	07-2002	Wurzer, Siegfried	386/46
	C	US-			
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	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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